

P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

NEL

The μ PA652TT is a switching device, which can be driven directly by a 2.5 V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

FEATURES

• 2.5 V drive available

Low on-state resistance $R_{DS(on)1} = 294 \text{ m}\Omega \text{ MAX.}$ (Vgs = -4.5 V, Ib = -1.0 A) $R_{DS(on)2} = 336 \text{ m}\Omega \text{ MAX.}$ (Vgs = -4.0 V, Ib = -1.0 A) $R_{DS(on)3} = 514 \text{ m}\Omega \text{ MAX.}$ (Vgs = -2.5 V, Ib = -0.5 A)

ORDERING INFORMATION

PART NUMBER	PACKAGE	
μ PA652TT	6pinWSOF (1620)	

Marking: WF

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	Vdss	-20	V
Gate to Source Voltage (VDS = 0 V)	Vgss	∓12	V
Drain Current (DC)	D(DC)	∓2.0	А
Drain Current (pulse) Note1	D(pulse)	∓8.0	А
Total Power Dissipation	P T1	0.2	W
Total Power Dissipation Note2	Рт2	1.3	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C

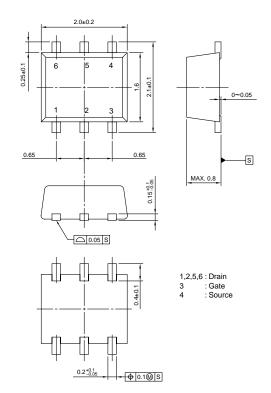
Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Mounted on FR-4 board of 5000 mm² x 1.1 mm, t \leq 5 sec.

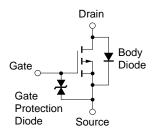
Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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PACKAGE DRAWING (Unit: mm)



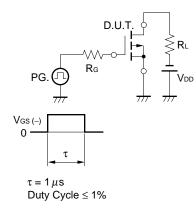
EQUIVALENT CIRCUIT

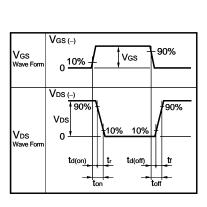


ELECTRICAL CHARACTERISTICS (TA = 25°C)

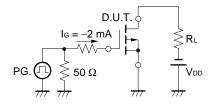
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	Idss	$V_{DS} = -20 V, V_{GS} = 0 V$			-10	μA
Gate Leakage Current	lgss	$V_{GS} = \mp 12 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			∓10	μA
Gate Cut-off Voltage	V _{GS(off)}	$V_{DS} = -10 \text{ V}, \text{ ID} = -250 \ \mu\text{A}$	-0.5	-1.1	-1.5	V
Forward Transfer Admittance	y _{fs}	V _{DS} = -10 V, I _D = -1.0 A	1.0	2.4		S
Drain to Source On-state Resistance	RDS(on)1	$V_{GS} = -4.5 \text{ V}, \text{ Id} = -1.0 \text{ A}$		235	294	mΩ
	RDS(on)2	Vgs = -4.0 V, Id = -1.0 A		252	336	mΩ
	RDS(on)3	$V_{GS} = -2.5 \text{ V}, \text{ Id} = -0.5 \text{ A}$		385	514	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V		126		pF
Output Capacitance	Coss	Vgs = 0 V		47		pF
Reverse Transfer Capacitance	Crss	f = 1.0 MHz		17		pF
Turn-on Delay Time	td(on)	$V_{DD} = -10 V$, $I_D = -1.0 A$		28		ns
Rise Time	tr	Vgs = -4.0 V		101		ns
Turn-off Delay Time	td(off)	R _G = 10 Ω		80		ns
Fall Time	tr			85		ns
Total Gate Charge	QG	Vdd = -16 V		1.1		nC
Gate to Source Charge	QGS	Vgs = -4.0 V		0.4		nC
Gate to Drain Charge	Qgd	ID = -2.0 A		0.5		nC
Body Diode Forward Voltage	VF(S-D)	IF = 2.0 A, VGS = 0 V		0.93		V

TEST CIRCUIT 1 SWITCHING TIME

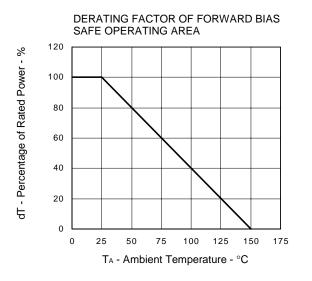


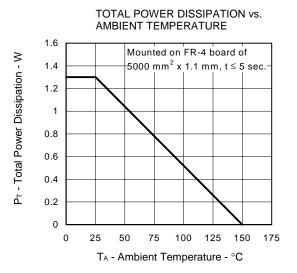


TEST CIRCUIT 2 GATE CHARGE

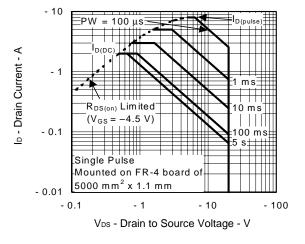


TYPICAL CHARACTERISTICS (TA = 25°C)

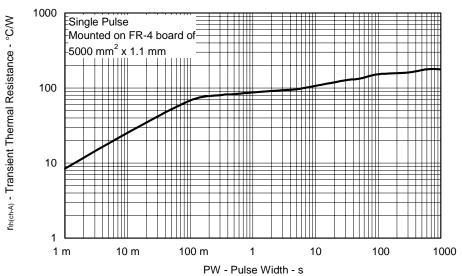




FORWARD BIAS SAFE OPERATING AREA



TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



- 1.6

- 1.4

- 1.2

- 1

- 0.8

- 0.6

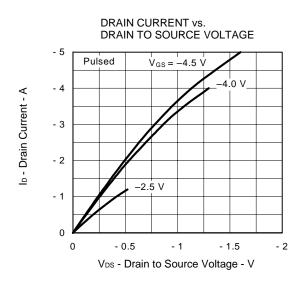
-50

V_{GS(off)} - Gate Cut-off Voltage - V

 $V_{DS} = -10$ V

 $I_{\rm D} = -250 \ \mu {\rm A}^2$

0



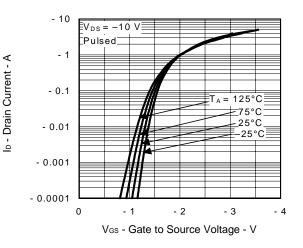
GATE CUT-OFF VOLTAGE vs.

50

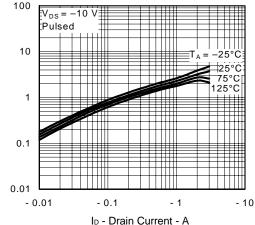
Tch - Channel Temperature - °C

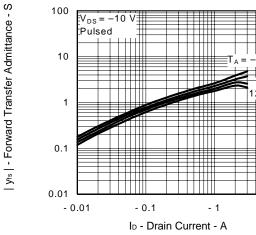
CHANNEL TEMPERATURE





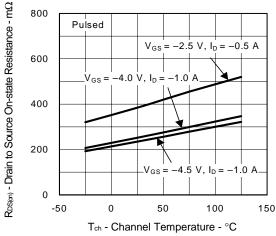
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT





 $R_{DS(m)}$ - Drain to Source On-state Resistance - $m\Omega$

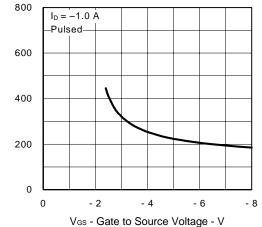
150



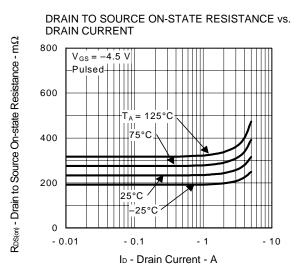
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE

100

DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

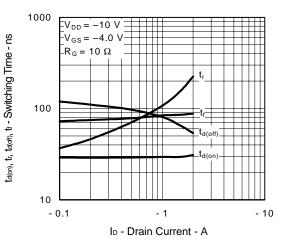


4

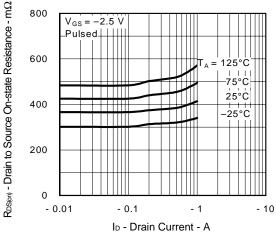


DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT $\mathsf{R}_{\mathsf{DS}(m)}$ - Drain to Source On-state Resistance - $m\Omega$ 800 $V_{GS} = -4.0 V$ Pulsed 600 $T_A = 125^{\circ}C$ 75°C 400 200 25°C 25 0 - 0.01 - 0.1 - 1 - 10 ID - Drain Current - A

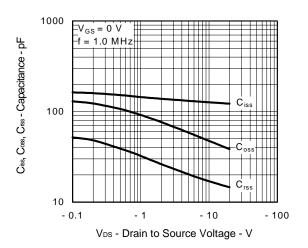
SWITCHING CHARACTERISTICS

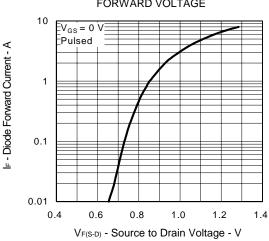


DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT 800



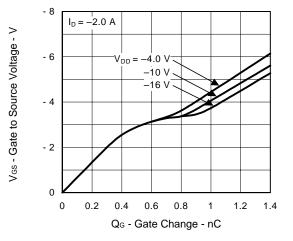
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE





SOURCE TO DRAIN DIODE FORWARD VOLTAGE

DYNAMIC INPUT/OUTPUT CHARACTERISTICS



[MEMO]

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